	Application No.	Applicant(s)
Notice of Allowability	10/749,505	TANAKA ET AL.
	Examiner	Art Unit
	M. Wilczewski	2822
The MAILING DATE of this communication app All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85; NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT R of the Office or upon petition by the applicant. See 37 CFR 1.31;	(OR REMAINS) CLOSED in or other appropriate comming IGHTS. This application is:	n this application. If not included unication will be mailed in due course. THIS
1. \boxtimes This communication is responsive to <u>the RCE and Amend</u>	ment filed on 31 October 20	<u>07</u> .
2. The allowed claim(s) is/are <u>10-28,36,37,39-48 and 50-81</u> .		
 3. Acknowledgment is made of a claim for foreign priority uses a) All b) Some* c) None of the: 1. Certified copies of the priority documents have 		or (f).
Certified copies of the priority documents have	e been received in Application	on No
Copies of the certified copies of the priority do	cuments have been receive	d in this national stage application from the
International Bureau (PCT Rule 17.2(a)).		
* Certified copies not received:		
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONN THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. 4. A SUBSTITUTE OATH OR DECLARATION must be subm	IENT of this application.	
INFORMAL PATENT APPLICATION (PTO-152) which give	es reason(s) why the oath o	r declaration is deficient.
5. CORRECTED DRAWINGS (as "replacement sheets") must	st be submitted.	
(a) ☐ including changes required by the Notice of Draftspers		w (PTO-948) attached
1) 🗌 hereto or 2) 🔲 to Paper No./Mail Date		
(b) including changes required by the attached Examiner Paper No./Mail Date	s Amendment / Comment or	r in the Office action of
Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in t	.84(c)) should be written on t the header according to 37 CF	he drawings in the front (not the back) of FR 1.121(d).
 DEPOSIT OF and/or INFORMATION about the depo attached Examiner's comment regarding REQUIREMENT 	SIT OF BIOLOGICAL MATE FOR THE DEPOSIT OF BIO	ERIAL must be submitted. Note the DLOGICAL MATERIAL.
Attachment(s) 1. ☐ Notice of References Cited (PTO-892)	E □ Notice of In	formal Patent Application
2. Notice of Draftperson's Patent Drawing Review (PTO-948)	6. Interview S	ummary (PTO-413),
3. Information Disclosure Statements (PTO/SB/08),		/Mail Date Amendment/Comment
Paper No./Mail Date <u>31 October 2007</u> 4. ☐ Examiner's Comment Regarding Requirement for Deposit of Biological Material	8. 🗌 Examiner's	Statement of Reasons for Allowance
oi biological Material	9.	
		M. Wilczewski Primary Examiner Tech Center 2800

Application/Control Number: 10/749,505

Art Unit: 2822

EXAMINER'S AMENDMENT

An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

The abstract of the disclosure is objected to because it is not limited to a single paragraph. Accordingly, the abstract has been rewritten as follows:

ABSTRACT OF THE DISCLOSURE

In a laser irradiation system, since a heavy scanning stage moves at a high speed, vibration is caused. When the vibration is transmitted to a vibration isolator where an optical system that forms a beam spot and a system are mounted, a laser irradiation track formed on a substrate, which is not linear any more, is undulating in a reflection of the vibration. It is one of the objects of the present invention to suppress the undulation of the irradiation tracks due to such vibration. A light-shielding film 134 is provided over a semiconductor film 133 that is to be irradiated. When the light-shielding film 134 is provided, a portion of the incident beam, which has a low energy density, is shielded. As described above, providing the light-shielding film 134 makes it possible to enlarge a grain size in the semiconductor film without forming the state similar to the crystals formed in the case of performing laser crystallization with an excimer laser. It is preferable that the light-shielding film 134 be as thin as possible in order to minimize an effect of diffraction.

Figure 3 was selected as the drawing to be printed on the front page of the patent, so the reference numbers used in the abstract have been changed to those used in Figure 3.

Art Unit: 2822

Reasons for Allowance

The following is an examiner's statement of reasons for allowance:

None of the references of record teach or suggest irradiating a laser beam to a semiconductor film through an opening in a light-shielding film formed on the semiconductor film while relatively moving the substrate in a direction of a minor axis of a beam spot of the laser beam.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to M. Wilczewski whose telephone number is (571) 272-1849. The examiner can normally be reached on Monday-Thursday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Zandra Smith can be reached on 571-272-2429. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Application/Control Number: 10/749,505

Art Unit: 2822

Page 4

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

M. Wilczewski Primary Examiner Tech Center 2800